

Search Notes



Application/Control No.

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Examiner

Nhon T. Diep

Applicant(s)/Patent under Reexamination

NISHIO ET AL.

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
375	240.01 240.29	2/8/08	N.D.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search History			
Print-out		2/19/08	N.D.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventors Search	2/19/08	N.D.